

Log-correlated fields: A Some useful tools Aug. 23,2021 Plan 1) Log-correlated field? Examples 2) Typical questions 3 Methods: · (Path) localization, first tsecond moment method · Genealogical structure: Seperation of Scales · Gaussian comparison / Berry-Essen bounds · Non Gaussian<sup>2</sup> 1 Log-correlated fields Abstractly speaking: Vn metric space with distance d (Xy(n), vGVn) log-corvelated  $i \notin E(X_v(n) X_v(n)) \approx -\log(d(v,v'))$ for viviely. ~ s Slow decay of correlations

Examples

Ex1 Binary branching random walk with Gaussian increments.



2<sup>n</sup> leaf. on each edge iid N(0, 1).

- Vn = set of legs.

Xv (n) = sum of weights on path to Ive Vn

 $X_v(n) \sim \mathcal{N}(O,n)$ 

Coure lation:

 $E(X_v(n|X_v(n)))$ = # edges that 3 path v-s root3 and 3 path V wroot 3 share.

branching time.

=: V AVI Overlap of V and V,

Some nice properties: · Decomposition in indep. increments · branching time : very explicit

before : fall dependence after complete independence. · Set similarity: Look at level k: 2<sup>k</sup> copies of BRW's with n-k levels Controlep. K h-k Ex 2 Branching Brownian motion (1) Start on BM at O.
(2) After exp(1) split in two.
(3) New particles perform indep MMMMMMM 2 After exp(1) split in two (3) New particles perform indep BM from splitting location (4) Same splitting vale. At time t: n(t) number of particles  $\mathbb{E}(n(t)) = e^{t}$ ₹XK(f), KEn(f)} particle postions.  $X_{k}(t) \sim \mathcal{N}(0, t)$ 

Ex3 2d DGFF Vn finite square of Z<sup>2</sup> n indicating the size P: law of SRW S starting from velo H Gowern expect. Ev corresp. expect. En exit fine of Vn. RXv(n), vEVny Gaussian process with mean Zero and covariance  $E[X_v(n)X_v(n)] = E_v \sum_{k=0}^{m} N_{S_k} = v^{-1}]$  $= G_{h}(v_{i}v')$ As d=2 : Gn behaves like log! Riemann zeta function  $S(s) = \sum_{n=1}^{2} \frac{1}{ns} = \prod_{p \text{ primes}} (1 - p^{-s})^{-1}$ Ex 4 Critical axis:  $\frac{1}{2}$  + it , te R. Choose an interval of length 1 uniformly from [O,T] large. Look at 35 (12+i+), + erandon inf. 3 This looks very much like a log-correlated fields!

Ex5 Log of characteristic polynomial for (some) random matrix ensembles For example: CUE NXN matrix unitary sampled uniformly from the unitary group. Pun (O) characteristic polynomial log (Pun (O)) is essentially log-correlated 2) What are questions of interest? (1) Level sets 2) Extreme values - P · Max 2 Expression + O(1) fluctations · Extremal process · Quantitative veselts 3) Gaussian multiplicative chaos. "eg. Field(x) " dx Size parameter - 2000: Convergence when properly normalized? If z < y < . Limit object GMC

y > y = : Extremes 3 Extremes · {X,(n)} binary BRW n-levels. · Upper bound on max X, (n)  $\mathbb{P}(\max_{v \in V_n} X_v(n) > Y)$  $= \| P(\sum_{v \in V_{h}} \| X_{v}(n) > y) \ge 1 )$  $\underbrace{Markov}_{\leq} E\left(\sum_{v \in V_n} \mathcal{N}_{\mathcal{X}_v(n) > \mathcal{Y}_{\mathcal{Y}_v}}\right)$  $= \sum_{v \in V_n} P(X_v(n) = y)$   $= 2^n P(X(n) = y)$   $= 2^n P(X(n) = y)$   $= \sum_{v \in V_n} P(X(n) = y)$ Find y such that this is of order 1.  $\gamma = 12\log^2 h + o(n)$ Good choice:  $y = 12 \log 2' n - \frac{1}{212 \log 2} \log n$ 

 $\begin{aligned} I & C \text{ is large constant and we take} \\ y &= \frac{1}{2 \log 2 \ln - \frac{1}{2 \log 2}} \log h + C \end{aligned}$ Then IP (max X, (n) > y) small. Result: Pescht  $12\log_2 n - \frac{1}{2\sqrt{2\log_2}}\log n + O(1)$ first upper bound on max. Note We have not used anything about BRW! Apart from: 2" r.v. Each v.v.  $\mathcal{N}(O_1 n)$ For example: Same computation with 2° iid  $\mathcal{N}(O_1 n)$ . la fact: 12log2n - 1 212log2 logn +0(1) is the order of max. of 2<sup>n</sup> id Ncon. In fact True answer for BRW: max 2 12log2 n - 3 logn + O(1)

What we have not used: K level ~> 2<sup>k</sup> Gaessians with variancek. L) Try to do better tomorrow!

Universality: Long correlated models

(-) iid set-up max have sume first order and

in the second order replace 103!